SUPPLEMENTAL MATERIAL

for the paper:

ELECTRON TRANSPORT AND ELECTRON DENSITY INSIDE DISORDERED QUASI-ONE-DIMENSIONAL CONDUCTORS

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I. CALCULATION OF THE INTENSITY IN THE BALLISTIC REGIME

The submatrix $\alpha$ of the transfer matrix (Eq. (A2) of the main text) for the full system is given in terms of the polar parameters of the two individual sections of the wire as

$$\alpha = \left( u_2 \sqrt{1 + \lambda_2 v_2} \right) \left( u_1 \sqrt{1 + \lambda_1 v_1} \right) + \left( u_2 \sqrt{\lambda_2^* v_2} \right) \left( u_1^* \sqrt{\lambda_1 v_1} \right).$$  \hfill (1.1)

The transmission matrix $t$, written in Eq. (A4b) of the main text as $t = 1/\alpha^\dagger$, is given, in the ballistic regime, up to terms $\lambda_i^{3/2}$, by

$$t = u_2 v_2 \left[ I_N - \frac{1}{2} u_1 \lambda_1 u_1^\dagger - \frac{1}{2} v_2 \lambda_2 v_2 - (u_1 \sqrt{\lambda_1 u_1^T})(v_2 \sqrt{\lambda_2 v_2}) + O(\lambda_i^2) \right] u_1 v_1. \hfill (1.2)$$

The terms $\alpha_i^\dagger t$ and $\beta_i^\dagger t$, appearing in Eq. (2.9a) of the main text, then take the form

$$\alpha_i^\dagger t = u_1 v_1 - \frac{1}{2}(u_1 \lambda_1 v_1) - (u_1 \sqrt{\lambda_1 u_1^T})(v_2 \sqrt{\lambda_2 v_2}) u_1 v_1 + O(\lambda_i^2) \hfill (1.3a)$$

$$\beta_i^\dagger t = (v_2 \sqrt{\lambda_2 v_2}) u_1 v_1 + O(\lambda_i^{3/2}). \hfill (1.3b)$$

Substituting expressions (1.3a) and (1.3b) in Eq. (2.9a) of the text, we find

$$W(x) = \sum_n \tilde{k}_n \left\{ 1 - 2Re \left[ e^{-2ik_0 x} (v_2^T \sqrt{\lambda_2 v_2}) \right]_{nn} - (u_1 \lambda_1 u_1^T)_{nn} + (v_2 \lambda_2 v_2)_{nn} -2Re \left[ (u_1 \sqrt{\lambda_1 u_1^T})(v_2 \sqrt{\lambda_2 v_2}) \right]_{nn} + O(\lambda_i^{3/2}) \right\}.$$  \hfill (1.4)

In an equivalent-channel (EC) approximation, $k_n^{EC} \equiv k_0 \forall n$, an ensemble average of the logarithm of the intensity can be written, upon expanding the logarithm, as

$$\left\langle \ln \frac{W(x)}{N} \right\rangle_{s \ll 1, EC} = -\frac{2}{N} \sum_n \tilde{k}_n \left\{ -\frac{1}{N} Tr \langle \lambda_1 \rangle_{s_1} -\frac{1}{N} Tr \langle \lambda_2 \rangle_{s_2} -\frac{2}{N} Re Tr \left[ \left\langle u_1 \sqrt{\lambda_1 u_1^T} \right\rangle_{s_1} \left\langle v_2 \sqrt{\lambda_2 v_2} \right\rangle_{s_2} \right] -\frac{1}{2N^2} \left\langle e^{-2ik_0 x} Tr \left( v_2^T \sqrt{\lambda_2 v_2} \right) + e^{2ik_0 x} Tr \left( v_2^\dagger \sqrt{\lambda_2^* v_2} \right) \right\rangle_{s_1,s_2}^2 + O(\lambda_i^{3/2}) \right\}.$$  \hfill (1.5)

In Eq. (1.5a) we have

$$Tr \left\langle v_2^T \sqrt{\lambda_2 v_2} \right\rangle_{s_2} = \sum_{ab} \sqrt{\langle \lambda_2 \rangle_{s_2}} \langle (v_2)_b (v_2)_a \rangle_0 = 0 \hfill (1.6a)$$
the index 0 indicating an average on the group $U(N)$, evaluated with the invariant measure. In Eq. (1.5b) we have

$$-\frac{1}{N} \Tr \langle \lambda_1 \rangle_{s_1} = -\frac{1}{N} N \frac{L_1}{\ell} = \frac{L_1}{\ell} = -\frac{x}{\ell} \quad \text{(1.6b)}$$

In Eq. (1.5c) we have

$$\frac{1}{N} \Tr \langle \lambda_2 \rangle_{s_2} = \frac{1}{N} N \frac{L_2}{\ell} = \frac{L_2}{\ell} = \frac{L - x}{\ell} \quad \text{(1.6c)}$$

In Eq. (1.5d), by the same argument as in (1.5a), we find

$$\langle u_1 \sqrt{\lambda_1} u_1^T \rangle_{s_1} \langle v_2 \sqrt{\lambda_2} v_2 \rangle_{s_2} = 0 \quad \text{(1.6d)}$$

In Eq. (1.5e) we have, upon expanding the square, the following terms

$$\left\langle \left[ \Tr \left( v_2^T \sqrt{\lambda_2} v_2 \right) \right]^2 \right\rangle = 0 \quad \text{(1.6e)}$$

$$\left\langle \left[ \Tr \left( v_2^T \sqrt{\lambda_2} v_2^* \right) \right]^2 \right\rangle = 0 \quad \text{(1.6f)}$$

$$\left\langle \Tr \left( v_2^T \sqrt{\lambda_2} v_2 \right) \Tr \left( v_2^T \sqrt{\lambda_2} v_2^* \right) \right\rangle = \frac{2}{N + 1} N \frac{L_2}{\ell}, \quad \text{(1.6g)}$$

which give, for (1.5e)

$$\text{(1.5e)} = -\frac{2}{N(N + 1)} \frac{L_2}{\ell}. \quad \text{(1.6h)}$$

Putting the various terms together, we find the result (3.3) of the text.

II. THE LOCALIZED REGIME

In order to compute the expectation value appearing in Eq. (3.21) of the main text, we first define the unitary, symmetric matrix $s = vv^T$ and its eigenvalues $e^{i\theta_a}$. We can write

$$\sum_{a,n=1}^{N} v_{an} v_{an} = \Tr(vv^T) \quad \text{(2.1a)}$$

$$\equiv \Tr s = \sum_{a=1}^{N} e^{i\theta_a} \quad \text{(2.1b)}$$

with: $ss^\dagger = I, \quad s = s^T.$ \quad \text{(2.1c)}
If \( v \) is distributed according to the invariant measure of the group \( U(N) \), \( s \) is distributed according to the invariant measure of unitary, symmetric \( N \)-dimensional matrices, and its eigenvalues according to the distribution

\[
p(\theta_1, \cdots, \theta_N) = C_N \prod_{1=a<b}^N |e^{i\theta_a} - e^{i\theta_b}|.
\]

(2.2)

The expectation value in Eq. (3.21) of the main text can thus be written as

\[
\langle \ln \frac{W(0)}{N} \rangle_{s \gg N, EC} = \langle \ln \left( 1 - \frac{1}{N} \sum_{a=1}^N \cos \theta_a \right) \rangle_{0} + \ln 2
\]

(2.3a)

\[
= \int_0^{2\pi} \cdots \int_0^{2\pi} \ln \left( 1 - \frac{1}{N} \sum_{a=1}^N \cos \theta_a \right) p(\theta_1, \cdots, \theta_N) d\theta_1 \cdots d\theta_N + \ln 2.
\]

(2.3b)

Here, the index 0 indicates that the average over \( v \) is computed according to the invariant measure of the unitary group \( U(N) \).

As an example, Eq. (2.3b) gives, for \( N = 1 \),

\[
\langle \ln W(0) \rangle_{s \gg 1, EC} = \int_0^{2\pi} \ln(1 - \cos \theta) \frac{d\theta}{2\pi} + \ln 2 = -\ln 2 + \ln 2 = 0,
\]

(2.4)

verifying the result of Ref. [3].

For \( N = 2 \), Eq. (2.2) gives

\[
p(\theta_1, \theta_2) = \frac{1}{8\pi\sqrt{2}} \sqrt{1 - \cos(\theta_1 - \theta_2)}.
\]

(2.5)

The integral needed in Eq. (2.3b) was evaluated numerically, with the result

\[
\langle \ln \left( 1 - \frac{\cos \theta_1 + \cos \theta_2}{2} \right) \rangle_0 = \int_0^{2\pi} d\theta_1 \int_0^{2\pi} d\theta_2 \ln \left( 1 - \frac{\cos \theta_1 + \cos \theta_2}{2} \right) p(\theta_1, \theta_2)
\]

(2.6a)

\[
= -0.122351,
\]

(2.6b)

as quoted in Eq. (3.22) of the main text.

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We consider the problem of electron transport across a quasi-one-dimensional disordered multiply-scattering medium, and study the statistical properties of the electron density inside the system. In the physical setup that we contemplate, electrons of a given energy feed the disordered conductor from one end. The physical quantity that is mainly considered is the logarithm of the electron density, $\ln W(x)$, since its statistical properties exhibit a self-averaging behavior. We also describe a gedanken experiment, as a possible setup to measure the electron density. We study analytically and through computer simulations the ballistic, diffusive and localized regimes. We generally find a good agreement between the two approaches. The extension of the techniques that were used in the past to find information outside the sample is done in terms of the scattering properties of the two segments that form the entire conductor on each side of the observation point. The problem is of interest in various other branches of physics, as electrodynamics and elasticity.

I. INTRODUCTION

The problem of the electronic conductance in disordered mesoscopic systems has been of interest for many years (for a review, see Ref. \textsuperscript{1} and references cited therein). The equivalence of the electronic conductance expressed in units of the quantum of conductance and the transmittance \textsuperscript{1,2} has allowed studying the electronic transport in terms of the scattering properties of the system of interest. For very low temperatures and small chemical potential difference between the two terminals, the relevant scattering properties are those in the vicinity of the Fermi energy. That equivalence also allows many of the predictions of mesoscopic physics and localization theory to apply equally to the transport of quantum and classical waves \textsuperscript{4-11}.

In addition to studies of the conductance and transmission, which refer to physical quantities evaluated outside the sample, the statistics of transport inside random systems has also been studied for many years \textsuperscript{12-16}, and is of interest in other branches of physics as well, as it is representative of a more general wave-scattering problem in a quasi-one-dimensional (q1D) disordered system: e.g., an electromagnetic wave traveling in a disordered waveguide \textsuperscript{17} – the interest being in the energy density inside the structure –, or an elastic wave propagating in a disordered elastic waveguide \textsuperscript{18-19}.

In this paper, we study the statistical properties of the electron density inside a quasi-one-dimensional multiply-scattering medium. The system is fed with electrons of a given energy from one end of the disordered conductor and the electron density is evaluated along the conductor and outside. For 1D systems, this was done recently in Refs. \textsuperscript{17,20}. In Ref. \textsuperscript{20}, the expectation value $\langle W(x) \rangle$ of the intensity $W(x)$ at a distance $x$ from the entrance was calculated and compared with computer simulations. In Ref. \textsuperscript{17}, emphasis was put on the statistics of the logarithm of the intensity, $\ln W(x)$, which shows interesting scaling properties, in a way similar to the logarithm of the conductance in the conduction problem; theoretical predictions were compared with computer simulations and microwave experiments. In the present paper, we address the more complicated problem of the electron density inside q1D systems supporting more than one propagating mode or open channel ($N \geq 1$).

The study of the statistics of electron density in the interior of random samples is performed in terms of the scattering properties of the two segments that form the entire conductor on each side of the observation point. We apply to each of the two segments, considered to be statistically independent, the maximum-entropy approach (MEA) to random-matrix theory \textsuperscript{1} that was used in the past for the entire conductor. The MEA for the full conductor of Ref. \textsuperscript{1} is a random-matrix theory which leads to a Fokker-Planck equation, known as the Dorokhov-Mello-Pereyra-Kumar (DMPK) equation \textsuperscript{21,22}, governing the “evolution” with sample length $L$ of the probability distribution (PD) $p_L(M)$ of the system transfer matrix $M$. In the so-called dense-weak-scattering limit, the resulting PD for the full system is expected to give results insensitive to microscopic details, depending only on the mean-free-path (MFP) $\ell$.

The multichannel problem is more complicated than the 1D case that was studied in Refs. \textsuperscript{17,20}. Although we have not been able to solve the problem in its entirety, we have succeeded in finding a number of partial results, which we consider of sufficient interest to be discussed in the present publication, especially because they may encourage the development of methods towards their experimental verification. One possible experimental procedure is described in Sec. \textsuperscript{11D}.
Two comments are in order at this point:

i) In a real electrical conduction problem realized by inserting the system between two terminals (reservoirs) at different chemical potentials, the electron density inside the system would have to be calculated by adding the contribution of all incident energies at which electrons are fed by the reservoirs, with a weight given by the Fermi function of the respective reservoir. As was already mentioned, in the present paper we restrict the analysis to one energy, the more complete calculation being deferred to a later publication.

ii) As was mentioned earlier, the problem studied in this paper may arise in Quantum Mechanics (QM), describing electronic scattering in a disordered conductor, or, more generally, in a wave-scattering problem in a q1D disordered waveguide. In what follows, we shall refer specifically to the first type of problem and use the QM nomenclature, although the notions to be discussed below are applicable to a more general situation involving wave transport (see, e.g., Ref. [22], Sec. V-C, for an application to electromagnetic waveguides).

The paper is organized as follows. In the next section we describe the problem to be developed in the article, and give its general mathematical formulation. With a few exceptions, the quantity we shall put emphasis on is the logarithm of the intensity, \( \ln W(x) \). In Sec. III we discuss the various regimes of interest for this class of systems: Sec. III A deals with q1D systems in the ballistic regime \( (L/\ell \ll 1) \); we find, for instance, a linear dependence of \( \ln W(x) \) on the position \( x \). In Sec. III B we study the regime of a large number of open channels, \( N \gg 1 \) and for \( 0 < s \equiv L/\ell \ll N \), which includes the ballistic and the diffusive regimes: in this case, we were able to find results for the two endpoints of the conductor, \( x = 0, L \). Sec. III C deals with q1D systems in the localized regime, \( L \gg \xi = (N + 1)\ell, \xi \) being the localization length. For the left endpoint of the conductor, i.e., near the incident beam entrance, we find a concrete result for \( N = 2 \) open channels, and a rather general result for the right endpoint. In Sec. III D we describe a gedanken experiment, intended to represent a possible setup to measure the electron density. In Sec. IV we verify the theoretical predictions of the previous sections by means of computer simulations. We give our conclusions in Sec. V. Various appendices, as well as a number of Supplemental Material (SM) sections, are included, in order to prove certain specific results without interrupting the main flow of the paper.

II. THE INTENSITY INSIDE A DISORDERED ELECTRONIC CONDUCTOR WITH A QUASI-1D GEOMETRY, SUPPORTING \( N \) PROPAGATING MODES

Consider the q1D two-dimensional scattering problem illustrated in Fig. 1, \( x \) being the propagation direction and \( y \) the transverse direction, respectively; we contemplate incidence from the left side of the sample at one given energy. We shall refer specifically to the electron conduction problem and use the QM nomenclature, although, as was mentioned in the Introduction, our discussion is applicable to a more general problem involving wave transport [23].

The scattering system consists of \( n_T \) non-overlapping scattering units; \( n_1 \) and \( n_2 \) of these are located on the left and on the right of the observation abscissa \( x \), respectively. Each scattering unit has a random-potential profile in the \( y \)-direction, as described more precisely at the beginning of Sec. IV. The whole sample has length \( L \), width \( W \), and can support \( N \) open channels. Two successive scattering units are a distance \( d \) apart (see Fig. 1); \( d \) will always be taken as \( d < \lambda \), \( \lambda \) being the wavelength.

The scattering problem is defined, as usual, with boundary conditions at \( \pm \infty \) in the following way. We have plane waves incident from the left from \( -\infty \) in each of the \( N \) open channels, with amplitudes \( a_n^{(1)} \), \( n = 1, \ldots, N \). The effect of the scattering system is to produce reflected waves on the left and transmitted waves on the right.

The incident wave function can be written as

\[
\psi_{inc}(x, y) = \sum_{n=1}^{N} a_n^{(1)} \phi_+(E_n; x) \chi_n(y) \quad (2.1a)
\]

\[
= \sum_{n=1}^{N} \sqrt{\frac{U}{k_n}} |a_n^{(1)}| e^{i\phi_n} e^{ik_n y} \chi_n(y) \quad (2.1b)
\]
where
\[\phi_{\pm}(E_n; x) = \sqrt{\mu} \frac{e^{i k_n x}}{\sqrt{k_n}}, \quad \mu = \frac{m}{2 \pi h^2}, \quad a_n^{(1)} = \gamma e^{i \delta_m}.\]  
(2.1c)

\[E_n = \frac{\hbar^2 k_n^2}{2m} \frac{2m E}{\hbar^2} = k_n^2 + \left(\frac{n \pi}{W}\right)^2.\]  
(2.1d)

Here, \(\phi_{\pm}(E_n; x)\) are plane waves with longitudinal momentum \(\hbar k_n\), normalized as delta functions of the energy, and
\[\chi_n(y) = \sqrt{\frac{2}{W}} \sin \frac{n \pi y}{W}, \quad n = 1, \cdots, N,\]  
(2.2)

are the transverse wave functions for the \(N\) open channels.

The amplitudes of the plane waves incident from the left in each of the channels form an \(N\)-dimensional vector, to be indicated as \(a^{(1)}\). The amplitudes of the reflected waves will be described by the column vector \(r a^{(1)}\), \(r\) denoting the \(N \times N\) reflection matrix, and those of the transmitted waves on the right will be described by the column vector \(t a^{(1)}\), \(t\) being the \(N \times N\) transmission matrix (see Fig. 1).

Inside the conductor we consider a point situated between two successive scattering units, a distance \(\tau\) from the left side of the sample, as illustrated in Fig. 1. At \(x\), the wave function consists of \(N\) waves traveling to the right, whose amplitudes form the \(N\)-dimensional vector \(a\), and \(N\) waves traveling to the left, with amplitudes forming the vector \(b\), i.e.,
\[\psi(x, y) = \sum_{n=1}^{N} \left[a_n \phi_+(E_n; x) + b_n \phi_-(E_n; x)\right] \chi_n(y).\]  
(2.3)

For one configuration of disorder, we define the linear particle density, or intensity, at \(x\), designated as \(W(x)\), as the particle density \(\psi(x, y)^2\) integrated over the lateral dimension. Using orthonormality of the transverse wave functions \(\chi_n(y)\), we have
\[W(x) = \int_0^W |\psi(x, y)|^2 dy = \mu \sum_n \left|a_n \frac{e^{i k_n x}}{\sqrt{k_n}} + b_n \frac{e^{-i k_n x}}{\sqrt{k_n}}\right|^2.\]  
(2.4)

The amplitudes \(a_n, b_n\) can be calculated from the transfer matrices of the two portions of the conductor (a reminder of some general properties of transfer matrices can be found in App. A1) and the incident vector of \(a_n^{(1)}\), as explained in App. A2 (see also Refs. 17, 20). The intensity appearing in Eq. (2.3) becomes [see Eq. (A7)]
\[W(x) = \mu \sum_n \left|\sum_m \left[\frac{e^{i k_n x}}{\sqrt{k_n}} (\alpha^1_m t)_{nm} - \frac{e^{-i k_n x}}{\sqrt{k_n}} (\beta^1_m t)_{nm}\right] a_n^{(1)}\right|^2.\]  
(2.5)

Here, \(\alpha_2, \beta_2\) are the 11 and 12 blocks of the transfer matrix for the second portion of the wire, defined in App. A2. \(t\) is the transmission matrix for the full system, defined in App. A1. If we assume random phases \(\delta_m\), an average over \(\delta_m\) gives [see Eq. (2.14), third equation]
\[W(x)^\delta = \mu \sum_{n,m} \frac{1}{k_n} \left|e^{i k_n x} (\alpha^1_m t)_{nm} - e^{-i k_n x} (\beta^1_m t)_{nm}\right|^2 |a_m^{(1)}|^2.\]  
(2.6)

At the RHS of the sample, \(x = L\), we have \(\alpha_2 = 1_N\) (the \(N \times N\) unit matrix), \(\beta_2 = 0\), so that, from Eq. (2.6), the intensity is given by
\[W(L)^\delta = \mu \sum_{n,m} \frac{1}{k_n} |t_{nm}|^2 |a_m^{(1)}|^2.\]  
(2.7)

Notice that it is not possible to choose the incident probabilities \(|a_m^{(1)}|^2\) so as to have the intensity on the RHS of Eq. (2.7) proportional to the transmittance \(T = \sum_{nm} |t_{nm}|^2\), because \(|a_m^{(1)}|^2/k_n\) cannot be made independent of \(n\) and \(m\). For these incident probabilities we make the specific choice
\[|a_m^{(1)}|^2 = \frac{\tilde{k}}{\mu},\]  
(2.8a)

where \(\tilde{k}\) is any quantity with dimensions of a wavenumber. For later convenience, we choose it as
\[\frac{1}{k} = \frac{1}{N} \sum_{n=1}^{N} \frac{1}{k_n},\]  
(2.8b)

i.e., the channel geometric average of the longitudinal momenta \(k_n\). The intensity at \(x\), Eq. (2.6), and at the right end, \(x = L\), Eq. (2.7), averaged over the phases \(\delta_m\), are then given by
\[W(x)^\delta = \sum_{n,m} \frac{\tilde{k}}{k_n} \left|e^{i k_n x} (\alpha^1_m t)_{nm} - e^{-i k_n x} (\beta^1_m t)_{nm}\right|^2,\]  
(2.9a)
\[W(L)^\delta = \sum_{n,m} \frac{\tilde{k}}{k_n} |t_{nm}|^2.\]  
(2.9b)

The above choice for \(a_m^{(1)}\) gives, for the Quantum Mechanical current through the system, the result
\[\tilde{T}^\delta = \frac{\tilde{k}}{\mu} \sum_{n,m} |t_{nm}|^2 = \frac{\tilde{k}}{\mu} T,\]  
(2.10)

which is proportional to the transmittance \(T\). In contrast, only in an equivalent-channel (EC) approximation, \(k_n^{EC} \equiv k_0 \forall n\), is the intensity at \(L\), Eq. (2.9b), equal to the transmittance. Thus, the choice we have made for the incident probabilities, Eqs (2.8), has the following consequences: i) the various channels are fed with the
same weight, as in Ref. \[3\]: ii) the QM current through the system is proportional to the transmittance \(T\), also as in Ref. \[3\]; iii) in the absence of a system, Eq. (2.6) (which takes into account that the \(k_n\)s are \(N\) different numbers) gives \([W(x)]/N = 1\), which is the same result obtained in an EC approximation, \(k_n^{EC} = k_0\), which is frequently employed in this paper.

For simplicity in writing, in the future we shall omit the bar indicating a phase average, and write \(W(x)\) for the quantity on the LHS of Eq. (2.9a).

III. THE VARIOUS REGIMES

A. The ballistic regime

We discuss the intensity \(W(x)\) defined in Eq. (2.9a), for q1D systems in the ballistic regime, i.e., such that

\[
s \equiv \frac{L}{\ell} \ll 1.
\]

The intensity \(W(x)\), evaluated in the Supplemental Material (SM) \[24\], Sec. I, and given explicitly in Eq. SM(1.4), simplifies considerably in an EC model, \(k_n^{EC} = k_0\ \forall n\), giving

\[
\langle W(x) \rangle_{EC} = 1 - \frac{2}{N} \text{Re} \left[ e^{-2ik_0x} \text{Tr} (v_2^T \sqrt{\lambda_2} v_2) \right] - \frac{1}{N} \text{Tr} (\lambda_1) + \frac{1}{N} \text{Tr} (\lambda_2) - \frac{2}{N} \text{Re} \text{Tr} ((u_1 \sqrt{\lambda_1} u_1^T) (v_2^T \sqrt{\lambda_2} v_2)) + O(\lambda^{3/2}).
\]

We write our expressions employing the polar representation summarized in App. A.3 in which the transfer matrix is parametrized in terms of the matrices \(\lambda, u, v\): \(\lambda\) is a diagonal \(N\)-dimensional matrix with non-negative elements \(\lambda_n\ (n = 1, \ldots, N)\), and \(u, v\) are arbitrary \(N\)-dimensional unitary matrices.

The result \([3,2]\) applies to one configuration of disorder. As shown in SM, Ref. \[24\], Sec. I, the ensemble average of the logarithm of the intensity can be written, upon expanding the logarithm, as

\[
\langle \ln \frac{W(x)}{N} \rangle_{s \leq 1,EC} = \frac{(N-1)(N+2)}{N(N+1)} \frac{L-x}{\ell} - \frac{x}{\ell} + \langle O(\lambda^{3/2}) \rangle + \cdots.
\]

In the one-channel case, \(N = 1\), this result reduces to \(-x/\ell\) \([\text{independent of the system length (as long as } x < L]\), in agreement with the analysis of Ref. \[17\]. However, for \(N > 1\) the result \([3,3]\) acquires a dependence on \(s = L/\ell\).

This result will be compared with computer simulations in the next section.

Before concluding this section, we illustrate the dependence on the incident energy of some of the above results. Consider Eq. (3.3) for \(N = 1\), which, from Ref. \[17\], is valid \(\forall s\); i.e.,

\[
\langle \ln W(x) \rangle = -\frac{x}{\ell(k)}.
\]

The \(k\) dependence of the MFP can be written as \[25\]

\[
\frac{d}{\ell(k)} = \left( \frac{\sigma}{2k} \right)^2,
\]

where

\[
\sigma^2 = \langle u_r^2 \rangle, \quad r = 1, \ldots, N;
\]

\(d\) is the distance between successive scattering units, and \(u_r\) is the (random) intensity of the \(r\)-th potential, with \(u_r \in (-u_0, u_0)\) in our model (see Fig. 1). Then

\[
\langle \ln W(x) \rangle = -\frac{x}{d} \left( \frac{\sigma}{2k} \right)^2.
\]

In particular,

\[
\langle \ln W(L) \rangle = \langle \ln T \rangle = -n_r \left( \frac{\sigma}{2k} \right)^2.
\]

This last result tends to 0 as \(k\) increases (since \(T \to 1\), as it should; it is illustrated in Fig. 2).

B. The case of a large number of open channels.

From the ballistic to the diffusive regime

We now consider the case when the number of open channels is very large,

\[
N \gg 1,
\]

\(L/d = n_r\).
and for
\[ 0 < s = L/\ell \ll N, \]  
(3.7b)
conditions that cover the ballistic and diffusive regimes; we restrict the analysis to the two end points of the sample, i.e., \( x = 0, L \) for which we have explicit results.

We start from Eq. (B2), which gives the intensity at the left end of the sample and compute its expectation value. In the DMPK approach, \( \langle r_{nm} \rangle = 0 \), and \( \langle |r_{nm}|^2 \rangle \) is independent of \( n, m \), so that
\[
\langle r_{nm} \rangle = 0, \quad \langle |r_{nm}|^2 \rangle = \frac{(R)}{N^2} = \frac{N - (T)}{N^2} = \frac{1}{N} - \langle T \rangle, \quad (3.8a)
\]
\[
\text{in terms of the reflectance } R = \sum_{n,m} |r_{nm}|^2 \text{ and the transmittance } T = \sum_{n,m} |t_{nm}|^2. \text{ Since in the present regime the ensemble expectation value of the transmittance can be approximated as } [1]
\]
\[
\langle T \rangle \approx \frac{N}{1 + s}, \quad (3.9)
\]
Eq. (B2) gives, on average,
\[
\langle W(0) \rangle_N = 1 + \frac{1}{N} \left( \sum_{n,m} \tilde{k} \right) \left( \frac{1}{N} \frac{s}{1 + s} \right), \quad (3.10a)
\]
\[
= 1 + \frac{2s}{1 + s} \approx \begin{cases} s, & \text{for } s \ll 1, \\ 2 - \frac{1}{s}, & \text{for } 1 \ll s \ll N. \end{cases} \quad (3.10b)
\]
so for the logarithm of this expression we obtain
\[
\ln \langle W(0) \rangle_N = \ln \left( 1 + \frac{2s}{1 + s} \right) \approx \begin{cases} s, & \text{for } s \ll 1, \\ \ln 2 - \frac{1}{s}, & \text{for } 1 \ll s \ll N. \end{cases} \quad (3.11)
\]
At the right end of the sample, \( x = L \), Eq. (2.9b) gives
\[
\frac{W(L)}{N} = \frac{1}{N} \sum_{n,m} \tilde{k} \tilde{k}_n \langle |t_{nm}|^2 \rangle. \quad (3.12)
\]
In the DMPK approach we have
\[
\langle |t_{nm}|^2 \rangle = \frac{(T)}{N^2}, \quad (3.13a)
\]
\[
\approx \frac{1}{N} \frac{1}{1 + s}, \quad (3.13b)
\]
where we used the result (3.9), valid in the regime defined by Eqs. (3.9). Substituting in Eq. (3.12), we then find
\[
\langle W(L) \rangle_N = \frac{1}{1 + s} \quad (3.14a)
\]
\[
= \begin{cases} 1 - s + \cdots, & \text{for } s \ll 1, \\ 1 - \frac{s}{2} + \cdots, & \text{for } 1 \ll s \ll N, \end{cases} \quad (3.14b)
\]
\[
\ln \langle W(L) \rangle_N = -\ln(1 + s) \quad (3.14b)
\]
\[
= \begin{cases} -s + \cdots, & \text{for } s \ll 1, \\ -\ln s + \cdots, & \text{for } 1 \ll s \ll N. \end{cases}
\]
These results will be compared with computer simulations in the next section.

C. The localized regime

In this regime one finds \( N \) characteristic lengths \( \xi_n = (N+1)\ell \), \( n = 1, \ldots, N \). The conductance is dominated by \( \xi_1 = (N+1)\ell \equiv \xi \), which we call the localization length \( \xi \). Here we consider the length of the system to fulfill
\[
L \gg \xi = (N + 1)\ell. \quad (3.15)
\]
We restrict our analysis to the left and right ends of the sample, i.e., \( x = 0, L \).

In the localized regime, from Eq. (B4) we can approximate, in lowest order (\( \lambda_n \gg 1, \ n = 1, \ldots N \)), the logarithm of the intensity at the left end as
\[
\langle W(0) \rangle_s \gg N = 1 - \frac{1}{N} \sum_{n=1}^{N} \frac{\tilde{k}}{k_n} \sum_{a=1}^{N} (v_{an}v_{an}^* + v_{an}^*v_{an}) + \frac{1}{N} \sum_{n,m=1}^{N} \frac{\tilde{k}}{k_n} \left( \sum_{a=1}^{N} v_{an}v_{am}^* \right) \left( \sum_{b=1}^{N} v_{bm}v_{bn}^* \right). \quad (3.16)
\]
We notice that in the present approximation, \( \lambda_n \gg 1 \), any function of \( W(0)/N \) has no \( \lambda \) dependence left. The statistics of such a function will thus be independent of the system length \( s = L/\ell \). In particular, the tendency of \( \langle \ln[W(0)/N] \rangle \) to become independent of \( L/\ell \) as this parameter increases is verified in the computer simulation for two open channels, \( N = 2 \), to be discussed later in relation with Fig. 5. This result is similar to that found in the 1D case for the average of \( \ln W(x) \), which, for fixed \( x \), gives \( -x/\ell \) and is independent of \( L/\ell \) for arbitrary values of this parameter (of course, by definition, \( 0 < x < L \); see Ref. [17, Fig. 1 and related discussion].

As an illustration of the approximation we have used, the reflection coefficient \( R_{mn} = |r_{mn}|^2 \) of Eq. (B3) and the total reflection coefficient \( R_n = \sum_m R_{mn} \) would be given, in the same approximation, by
\[
R_{mn} \approx \sum_{a,b=1}^{N} v_{an}v_{am}^*(v_{bn}v_{bm}^*) \quad (3.17a)
\]
\[
R_n = \sum_{m=1}^{N} R_{mn} \approx \sum_{a,b=1}^{N} v_{an}v_{am}^* \sum_{m=1}^{N} v_{bm}v_{bn}^* = \sum_{a,b=1}^{N} v_{an}v_{bn}^* \delta_{ab} = \sum_{a=1}^{N} v_{an}v_{an}^* = 1, \quad (3.17b)
\]
meaning that a wave incident in channel \( n \) is fully reflected into all \( N \) backward channels, with no transmission left. This is the crudest approximation to localization.

If we adopt an EC approximation, \( k_n^EC = k_0 \ \forall n \), Eq. (B3) reduces to
\[
\langle W(0) \rangle_s \gg N, EC = 2 - \frac{1}{N} \sum_{a,n=1}^{N} (v_{an}v_{an} + v_{an}^*v_{an}), \quad (3.18)
\]
The expectation value of the logarithm of (3.18) is then
\[
\langle \ln \frac{\mathcal{W}(0)}{N} \rangle_{s \gg N, EC} = \left\langle \ln \left[ 1 - \frac{1}{2N} \sum_{a,n=1}^{N} (v_{an}v_{an} + v_{an}^*v_{an}^*) \right] \right\rangle_0 + \ln 2 ,
\]
where the index 0 indicates an average over the matrices \( v \), distributed according to the invariant measure of the group \( U(N) \) [1]. This is evaluated in SM, Ref. 24, Sec. 2, for \( N = 2 \). From Eq. (2.6b)SM, we have
\[
\left\langle \ln \frac{\mathcal{W}(0)}{2} \right\rangle_{s \gg 2, EC} = -0.123251 + \ln 2 = 0.570796 .
\]
(3.20)

At the right end of the sample, \( x = L \), the intensity is given by Eq. (2.9b). Only in an EC approximation it coincides with the transmittance, i.e.,
\[
\mathcal{W}(L) = \sum_{m,n=1}^{N} |t_{mn}|^2 = T ,
\]
which, in the polar representation, is
\[
\frac{\mathcal{W}(L)}{N} = \frac{1}{N} \sum_{a=1}^{N} \frac{1}{1 + \lambda_a} .
\]
(3.21b)

In the localized regime, Eqs. (3.21) give
\[
\left\langle \ln \frac{\mathcal{W}(L)}{N} \right\rangle_{s \gg N, EC} = (\ln T)_{s \gg N} - \ln N \quad (3.22a)
\approx -2 \frac{L}{(N+1)\ell} - \ln N .
\]
(3.22b)

These results will be compared with computer simulations in the next section.

D. Measuring the electron density

Before closing this section, we describe a gedanken experiment, intended to represent a possible setup to measure the electron density that we have been studying in the previous sections. For simplicity, we shall deal with 1D conductors.

The main idea of the procedure is to introduce an additional wire, as a “probe” to measure the electron density at some point along the main wire, as illustrated in Figs. 3 and 4. This setup, devised by Büttiker for a number of other purposes [3], is similar to the one used in actual electromagnetic experiments, where an antenna is introduced at the point of interest to measure the electromagnetic energy density [15]. A “junction” joins the probe to the main wire.

\[
\begin{array}{c}
\alpha \text{e}^{ikx} \\
\beta \text{e}^{-ikx}
\end{array}
\quad \begin{array}{c}
S
\end{array}
\quad \begin{array}{c}
\alpha \text{e}^{-ikx} \\
\beta \text{e}^{ikx}
\end{array}
\]

FIG. 3: The setup used to measure the electron density at the point \( x = 0 \) of our 1D system. The symbol at \( x = 0 \) represents the junction used to join the “probe” wire to the main wire, described by the \( S \) matrix of Eqs. (3.20).

Consider first the probe being introduced at the point defined as \( x = 0 \) in Fig. 3. The incoming waves along the two portions of the main wire at \( x = 0 \) and along the probe are designated as \( \alpha_1 \text{e}^{ikx} \), \( \alpha_2 \text{e}^{-ikx} \) and \( \alpha_3 \text{e}^{-iky} \), and the corresponding outgoing waves as \( \beta_1 \text{e}^{-ikx} \), \( \beta_2 \text{e}^{ikx} \) and \( \beta_3 \text{e}^{iky} \). They are related by the junction scattering matrix \( S \), for which we take the simple model introduced in Ref. 3, as
\[
\begin{bmatrix}
\alpha_1 \\
\alpha_2 \\
\alpha_3
\end{bmatrix}
= S
\begin{bmatrix}
\beta_1 \\
\beta_2 \\
\beta_3
\end{bmatrix}
\]
(3.23a)
\[
S = \begin{bmatrix}
\alpha & \beta & 0 \\
\beta & \alpha & \sqrt{\epsilon} \\
0 & \sqrt{\epsilon} & -\sqrt{\epsilon} - (\alpha + \beta)
\end{bmatrix}
\]
(3.23b)

with \( \alpha, \beta \) real and given by
\[
\alpha = \frac{1}{2} \left[ 1 - \sqrt{1 - 2\epsilon} \right] \quad (3.24a)
\beta = \frac{1}{2} \left[ 1 + \sqrt{1 - 2\epsilon} \right] . \quad (3.24b)
\]
The coupling strength is described by the real parameter \( \epsilon \in [0, 1/2] \). Actually, we shall take \( \alpha_3 = 0 \), i.e., no incoming waves in the probe lead, and \( \beta_3 = \beta_3^* \), i.e., the transmitted amplitude along the probe lead.

Eqs. (3.23) then give
\[
\alpha_1 + \alpha_2 = \frac{t_3}{\sqrt{\epsilon}}.
\]
(3.25)

In the limit as the coupling strength \( \epsilon \to 0 \), we have \( \alpha_1 \to \hat{a}, \alpha_2 \to \hat{b} \), in the notation used in the previous sections for the amplitudes of the wave traveling to right and left at the point of interest (see Fig. 4), so that
\[
\left[ \frac{\alpha_1}{\hat{a}} \text{e}^{ikx} + \frac{\alpha_2}{\hat{b}} \text{e}^{-ikx} \right]_{x=0} = \lim_{\epsilon \to 0} \frac{t_3}{\epsilon} \quad (3.26)
\]
The square of the expression on the LHS is the intensity at the point \(x = \Delta\), and is thus expressed in terms of the transmission coefficient \(T_{\Delta}^{\Delta} = |t_{\Delta}^{\Delta}|^2\) measured along the probe lead, and the coupling strength \(\epsilon\), the latter being a characteristic of the junction.

Repeating this experiment over a large sample, we can find the required statistical properties of the intensity.

We now consider the probe being introduced at \(x = \Delta\), as in Fig. 4. The incoming waves along the two portions of the main wire at \(x = \Delta\) and along the probe are designated as \(a_{\Delta}^d e^{ikx}\), \(a_{\Delta}^d e^{-ikx}\) and \(a_{\Delta}^d e^{-ikx}\), and the corresponding outgoing waves as \(b_{\Delta}^d e^{ikx}\), \(b_{\Delta}^d e^{ikx}\) and \(b_{\Delta}^d e^{ikx}\). They are related by the junction scattering matrix \(S\), which can be expressed in terms of the previous junction scattering matrix \(s\) through the translation matrix \(D(kd)\) as (see Ref. 1)

\[
S = D(kd) s D(kd) ,
\]

\[
D(kd) = \begin{bmatrix}
ed^{ikd} & 0 & 0 \\
0 & e^{-ikd} & 0 \\
0 & 0 & 1
\end{bmatrix} .
\]

In the limit as the coupling strength \(\epsilon \to 0\), we have \(a_{\Delta}^d \to a_{\Delta}^d\), \(a_{\Delta}^d \to b_{\Delta}^d\), in the notation used in the previous sections for the amplitudes of the wave traveling to right and left at the point of interest (see Fig. 1), so that

\[
\lim_{x \to \Delta} \frac{d}{\Delta} a_{\Delta}^d e^{ikx} + \frac{d}{\Delta} b_{\Delta}^d e^{-ikx} = \lim_{x \to \Delta} \frac{t_{\Delta}^{\Delta}}{\epsilon} .
\]

The square of the expression on the LHS is the intensity at the point \(x = \Delta\), and is expressed in terms of the transmission coefficient \(T_{\Delta}^{\Delta} = |t_{\Delta}^{\Delta}|^2\) measured along the probe lead and the coupling strength \(\epsilon\), the latter being a characteristic of the junction.

Again, repeating this experiment over a large sample, we can find the required statistical properties of the intensity.

IV. COMPUTER SIMULATIONS

To check the theoretical results of the previous sections, we present a number of computer simulations of random q1D systems supporting \(N\) propagating modes, in which the disordered potential is a random function of position. We use the model employed in Ref. 25, in which the scattering units consist of thin potential slices, idealized as equidistant delta potentials (\(d\) being their separation), perpendicular to the longitudinal direction of the conductor, the variation of the potential in the transverse direction being random. This is illustrated in Fig. 1. The sets of parameters defining a given slice are taken to be statistically independent from those of any other slice and identically distributed. In the dense-weak-scattering limit, in which the potential strength of the slices is very weak and their linear density is very large, so that the resulting mean free paths are fixed, the corresponding statistical properties of the full system depend only on the mean free paths and on no other property of the slice distribution.

We first consider the left end of the sample, \(x = 0\). The quantity \(\ln(W(0)/N)\) was calculated numerically by a computer simulation for \(N = 2\) open channels, from the ballistic to the localized regime, as function of \(s = L/\ell\), as can be seen in Fig. 5. In the ballistic regime, corresponding to \(s \ll 1\), the result is in excellent agreement with (2/3)\(L/\ell\), as predicted by Eq. (3.3), which we re-
produce here

\[ \langle \ln \frac{W(x)}{N} \rangle_{s \ll 1} \approx \frac{(N - 1)(N + 2)}{N(N + 1)} \frac{L - x}{\ell} - \frac{x}{\ell} + \cdots, \]

(4.1)

evaluated at \( x = 0 \). The result is not \( L \) independent, as it is for \( N = 1 \). In the localized regime, \( s \gg N = 2 \), both the simulation (point marked \( \mathbf{B} \) in the figure) and theory tend asymptotically to \( \approx 0.57 \), a constant independent of \( s \).

Numerical results for the right end of the sample are given in panel \( \mathbf{a} \) for \( \langle \ln(W(L)/N) \rangle \), and in panel \( \mathbf{b} \) for \( \langle \ln(T/N) \rangle \). In panel \( \mathbf{c} \), we also show, for \( s \ll 1 \), the outcome of theoretical analysis [Eq. (4.1)] for \( \langle \ln(W(L)/N) \rangle_{s \ll 1} \), which is seen to agree well with the simulation, and in panel \( \mathbf{d} \) for \( \langle \ln(T/N) \rangle_{s \ll 1} \). Panels \( \mathbf{e} \) and \( \mathbf{f} \) also show the theoretical prediction of Eq. (3.22b) for \( s \gg N = 2 \), which we reproduce here

\[ \langle \ln \frac{W(L)}{N} \rangle_{s \gg N, EC} = \langle \ln \frac{T}{N} \rangle_{s \gg N} \approx -2 \frac{L}{(N + 1)\ell} - \ln N. \]

(4.2)

There is a difference between the simulations in panels \( \mathbf{e} \) and \( \mathbf{f} \), not noticeable in the figure, due to the two channels not having the same longitudinal momentum \( k_n \): compare \( W(x) \) in Eq. (2.9b) with \( T \) in Eq. (2.10). We see a discrepancy between theory and simulations for \( s \gg N = 2 \). A useful example to understand this discrepancy is to compare the behavior of \( \langle \ln R \rangle \) with that of \( \langle \ln T \rangle \) as \( s \) increases. Although one always has \( R + T = N \), the quantities \( \langle \ln R \rangle \) and \( \langle \ln T \rangle \) behave very differently. As \( s \) increases, \( \langle \ln R \rangle \) tends to \( \ln N \) for both theory and simulations. On the other hand, \( \langle \ln T \rangle \) is not bounded as \( s \) increases: it tends to \(-\infty \), so the difference between theory and simulations cannot be assessed a priori. In the present case there is a difference in value and slope of \( \langle \ln T \rangle \) vs \( s \) between theory and simulations, as seen in Fig. \( \mathbf{f} \): the two curves get farther apart for larger values of \( s \). In order to be more specific, one would need an improved theory beyond DMPK, such as the theories developed in Refs. 26-28.

Fig. \( \mathbf{f} \) shows, in panel \( \mathbf{a} \), the profile \( \langle \ln(W(x)/N) \rangle \) for \( N = 2 \) open channels as function of \( x \) for various values of \( s \), for the ballistic regime, \( s \ll 1 \), and slightly beyond, \( s \approx 1 \).

The theoretical prediction of Eq. (3.3), reproduced above in Eq. (4.1), agrees well with the computer simulations up to \( s \sim 0.3 \). The simulations show oscillations as function of \( x/\ell \), which are not reproduced by the DMPK treatment. On the other hand, these interference oscillations are described well by an analysis based on Born’s approximation, up to second order \( 29 \). Fig. \( \mathbf{g} \) shows the behavior of the profile \( \langle \ln(W(x)/N) \rangle \) for \( N = 2 \) channels as a function of \( x \), for various values of \( s \) in the localized regime. For \( x = 0 \), the theoretical result (i.e., 0.57) is given in Eq. (3.20); point \( \mathbf{B} \) (0.57, too) is the result of simulation. For \( x = L \), theory is that of Eq. (4.2), while \( \mathbf{A} \) is the simulation result. In the localized regime, as \( x \) goes from the left to the right edge of the sample, \( x = 0 \) to \( x = L \), the discrepancy between theory and simulations increases: it is imperceptible for \( x = 0 \) and very noticeable for \( x = L \), as shown in Fig. \( \mathbf{f} \). See the above discussion in relation with Figs. \( \mathbf{d} \) and \( \mathbf{c} \).

We compare, in Fig. \( \mathbf{c} \) theoretical results with computer simulations for the regime in which the number of open channels is very large, \( N \gg 1 \), and for \( 0 < s = L/\ell \ll N \). The theoretical description is given in Sec. 3.1.1.3 In the left panels, the theoretical results are taken

\[ \text{FIG. 6: Computer simulations of the profile } \langle \ln W(x)/N \rangle \text{ for } N = 2 \text{ open channels and some theoretical predictions. a) Numerical results for the ballistic regime and slightly beyond.} \]

\[ \text{b) Numerical results for the localized regime. Theory is given only for } x = 0 \text{ and } x = L, \text{ and is indicated by big dots. The origin of the discrepancy is probably the same as discussed in the text in relation with Fig. 6.} \]

\[ \text{FIG. 7: Computer simulations (dotted lines) and theoretical results (continuous lines) for the quantities shown in the various panels. The equations in Sec. 3.1.1.3 from which the latter are taken are indicated in the text. Results correspond to } 0 < s < N, \text{ and go from the ballistic to approximately the diffusive regime.} \]

\[ \text{We discuss in the text the quality of the agreement between the two calculations. Points marked as } \mathbf{C}, \mathbf{D}, \mathbf{E} \text{ and } \mathbf{F} \text{ represent numerical results which correspond to the ones marked similarly in Fig. 6.} \]
The physical quantity that was mainly considered was the logarithm of the electron density, $\ln W(x)$, since its statistical properties possess a self-averaging behavior, as was explained, for $N = 1$, in the supplemental material to Ref. [17]. The theoretical analysis in the present work was based on the DMPK model [1], and the results were compared with computer simulations.

We first examined the case in which the system is in the ballistic regime. We encountered, in Eq. (3.3), a linear dependence of $\langle \ln W(x) \rangle$ on the position $x$. Also, for $x = 0$, we found that the result is linear in $s = L/\ell$. For one open channel, $N = 1$, $\langle \ln W(x) \rangle = -x/\ell$ for $x \in (0, L)$ is independent of the system length $L$, a remarkable property shown in Ref. [17]; on the other hand, a dependence on $L$ appears in $\langle \ln W(x) \rangle$ if $N > 1$. Theoretical results are in good agreement with simulations. However, we should point out that the latter exhibit oscillations as a function of $x/\ell$, which are missed by the DMPK treatment. In contrast, these oscillations are reproduced by an analysis based on Born’s approximation, as studied in Ref. [24].

We then dealt with systems possessing a large number of propagating modes, or open channels, $N \gg 1$, when the parameters $s$ and $N$ fulfill $0 < s = L/\ell \ll N$, this inequality including the ballistic and the diffusive regimes. For $\langle W(x)/N \rangle$ at $x = 0$ we obtained the result (4.6), that goes from 1 to 2 as $s$ goes from 0 to the regime $s \ll N$. For $\langle W(x)/N \rangle$ at $x = L$ we found the typical $1/(1 + s)$ behavior of the average transmittance, Eq. (4.7). The theoretical results for this regime are in very good accordance with the computer simulations. We encountered evidence of a self-averaging property: judging from the good agreement between the expectation value of the logarithm of the electron density and the logarithm of the expectation value, the latter being the quantity that was amenable to a theoretical calculation.

We finally analyzed the q1D systems in the localized regime. In an equivalent-channel approximation, we obtained a rather general expression for $\langle \ln W(x) \rangle$ for $x = 0$, i.e., near the incident beam entrance on the left side of the sample, Eq. (3.19), which we could compute explicitly for two open channels, $N = 2$, Eq. (4.8), and compare with computer simulations. We also derived a rather general expression for $\langle \ln W(x) \rangle$ for $x = L$, as in this case of ECs it is directly connected with the transmittance. We noticed that, in the localized regime, as $x$ goes from the left to the right edge of the sample, $x = 0$ to $x = L$, the discrepancy between theory and simulations increases, becoming quite noticeable for $x = L$, as exhibited in Fig. 6. We conjectured that such a discrepancy is due to the approximations involved in the DMPK equation, like the isotropy assumption, whose influence is more apparent in the localized than in the diffusive regime; such an assumption has been relaxed in a number of models, like those presented in Refs. [26, 27].

The multichannel problem is more complicated than the 1D case that was studied in Refs. [17, 24]. As a matter of fact, because of technical difficulties we have not...
been able to compute theoretically, for any number of propagating modes \( N > 1 \) (as was done in Ref. [17] for \( N = 1 \)): i) the profile \( \ln W(x) \) for arbitrary positions \( x \) and for arbitrary \( s = L/l \), except for the particular positions and for the regimes \( s \) mentioned above; on the other hand, we reported on computer simulations for arbitrary values of these parameters; ii) the profile of the variance of \( \ln W(x) \), again for any \( x \) and \( s \). These problems remain open for future studies.

As was indicated in the Introduction, a real electrical conduction problem is modeled by placing the system between two reservoirs at different chemical potentials [18]. The electrons fed by the reservoirs at all energies, weighted by the respective Fermi function, would then contribute to the electron density inside the system. In contrast, in the present paper we restricted the analysis to the system being fed with electrons of a given energy from one end of the disordered conductor, and the electron density was then evaluated for that energy along the conductor and outside. The more complete calculation will be performed in a future publication.

We also described a gedanken experiment for 1D electric conductors, intended to represent a possible experimental setup to measure the electron density that was studied in this paper. This possible suggested experiment would complement those that have been performed in the classical domain, as in electromagnetic disordered waveguides [17] and in elastic media [18,19].

Appendix A: Technical details

1. Some properties of the transfer matrix

By definition, the transfer matrix \( M \) for the full system relates the amplitudes on the RHS, \( a^{(2)}, b^{(2)} \), to those on the LHS, \( a^{(1)}, b^{(1)} \), as

\[
M \begin{bmatrix} a^{(1)} \\ b^{(1)} \end{bmatrix} = \begin{bmatrix} a^{(2)} \\ b^{(2)} \end{bmatrix} ;
\]

(1)

\( M \) is a \( 2N \times 2N \) matrix, with the structure

\[
M = \begin{bmatrix} \alpha & \beta \\ \beta^* & \alpha^* \end{bmatrix} ,
\]

(2)

satisfying the properties of time-reversal and flux conservation, as

\[
M^\dagger \Sigma_2 M = \Sigma_2 ,
\]

(A3a)

\[
M^* = \Sigma_2 M \Sigma_x ,
\]

(A3b)

respectively. Here, \( \Sigma_2 \) and \( \Sigma_x \) are the \( 2N \times 2N \) generalization of Pauli matrices \( \sigma_z \) and \( \sigma_x \). The \( N \)-dimensional blocks of the \( M \) matrix are related to the reflection and transmission matrices \( r, t \) for left incidence and \( r', t' \) for right incidence as

\[
r = - (\alpha^*)^{-1} \beta^* , \quad t' = (\alpha^*)^{-1} ,
\]

(A4a)

\[
t = (\alpha^\dagger)^{-1} , \quad r' = (\beta^*)^{-1} .
\]

(A4b)

2. Calculation of the amplitudes \( a_n, b_n \) appearing in Eq. (2.4)

The transfer matrices of the two portions of the wire are denoted by

\[
M_i = \begin{bmatrix} \alpha_i & \beta_i \\ \beta_i^* & \alpha_i^* \end{bmatrix} , \quad i = 1, 2.
\]

(5)

From the definition of the transfer matrix, we have

\[
M_2 \begin{bmatrix} a \\ b \end{bmatrix} = \begin{bmatrix} t a^{(1)} \\ 0 \end{bmatrix} ,
\]

(6)

so that the amplitudes between the two portions are given by

\[
\begin{bmatrix} a \\ b \end{bmatrix} = \begin{bmatrix} (\alpha_1^\dagger t) a^{(1)} \\ - (\beta_1^\dagger t) a^{(1)} \end{bmatrix} , \quad t = \frac{1}{\alpha^\dagger} = \frac{1}{\alpha_1 \alpha_2 + \beta_1^\dagger \beta_2^*} .
\]

(A7)

This result is used in Eq. (2.5).

3. The polar representation

From Ref. [1], a transfer matrix \( M \) can be represented as

\[
M = \begin{bmatrix} u & 0 \\ 0 & u^* \end{bmatrix} \begin{bmatrix} \sqrt{1 + \lambda} & \sqrt{\lambda} \\ \sqrt{\lambda} & \sqrt{1 + \lambda} \end{bmatrix} \begin{bmatrix} v & 0 \\ 0 & v^* \end{bmatrix} .
\]

(A8)

Here, \( u \) and \( v \) are \( N \times N \) arbitrary unitary matrices; \( \lambda \) is an \( N \times N \) diagonal matrix with elements \( \lambda_n \geq 0 \), \( n = 1, \ldots, N \).

The reflection matrix \( r \) can be expressed as

\[
r = - v^T \sqrt{\frac{\lambda}{1 + \lambda}} v
\]

(A9)

These results are used in Sec. II.

Appendix B: Exact result for \( x = 0 \)

For \( x = 0 \), using Eq. (A7) (see also Ref. [1] for the relation between the transfer matrix and the \( S \) matrix) we have

\[
\alpha_2 = \alpha = \frac{1}{t} , \quad \alpha_2^\dagger t = \mathbb{I}_N , \quad a = a^{(1)} ,
\]

(B1a)

\[
\beta_2 = \beta = - \frac{1}{t^*} r^* , \quad - \beta_2^\dagger t = r^T = r , \quad b = ra^{(1)} .
\]

(B1b)

Eq. (2.9a) then gives

\[
W(0)/N = 1 + \frac{1}{N} \sum_{n=1}^{N} \frac{1}{k_n} (r_{nn} + r_n^*) + \frac{1}{N} \sum_{n,m=1}^{N} \frac{k_n}{k_m} |r_{nm}|^2 .
\]

(B2)
Using the polar representation parameters introduced in App. [A3] we can write the reflection matrix \( r \), its matrix elements, and the reflection coefficients as

\[
 r = -v^T \sqrt{\frac{\lambda}{1 + \lambda}} v, \quad (B3a)
\]

\[
 r_{nm} = -\sum_{a=1}^{N} v_{an} v_{am} \sqrt{\frac{\lambda_a}{1 + \lambda_a}}, \quad (B3b)
\]

\[
 R_{nm} \equiv |r_{nm}|^2 = \sum_{a,b=1}^{N} \lambda_a \lambda_b \left( \frac{1}{1 + \lambda_a} \right) v_{an} v_{am}^* v_{bn} v_{bm}, \quad (B3c)
\]

Substituting in Eq. (B2), \( W(0)/N \) becomes

\[
 W(0) = 1 - \frac{1}{N} \sum_{n=1}^{N} \sum_{a=1}^{N} \frac{k_n}{\lambda_a} \left( v_{an} v_{an}^* + v_{an}^* v_{an} \right) + \frac{1}{N} \sum_{n,m=1}^{N} \sum_{a,b=1}^{N} \sqrt{\lambda_a \lambda_b} \left( v_{an} v_{am} v_{bn} v_{bm}^* \right). \quad (B4)
\]

This result is valid for any regime \( L/\ell \). It is used in Secs. [III.B] and [III.C].

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24. See Supplemental Material at [http://...](http://...) for the calculation of the logarithm of the intensity in the ballistic and in the localized regimes.